

Notice of References Cited	Application/Control No. 10/726,075		Applicant(s)/Patent Under Reexamination TAI ET AL.	
	Examiner Phillip H. Nguyen		Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,898,751	05-2005	Aikawa et al.	714/748
*	B	US-6,145,045	11-2000	Falik et al.	710/310
*	C	US-6,357,021	03-2002	Kitagawa et al.	714/41
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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